Roll	No.:

: 111

National Institute of Technology

Name of the Examination: B. Tech

Branch : ECE Semester

Title of the Course : Electronic Devices and Course Code : EC 201

Circuits - I

Time: 3 Hours Maximum Marks: 50

Note:

- Questions are printed on BOTH sides. Answers should be CLEAR ANDTO THE POINT.
- All parts of a single question must be answered together. ELSE QUESTION SHALL NOT BE EVALUATED.

Use following data if not given in a problem: $\epsilon_o = 8.85 \times 10^{-14} F/cm$, $\epsilon_r (SiO_2) = 3.9$, $\epsilon_r (Si) = 11.8$, At room temperature for Si [$\mu_n = 1350 cm^2/V \cdot S$, $\mu_p = 480 cm^2/V \cdot S$, $n_i = 1.5 \times 10^{10}/cm^3$, $E_g = 1.12 eV$], $k = 8.62 \times 10^{-5} ev/K$, $\tau_n = \tau_p = 1 \mu s$, $E_g(Ge) = 0.7 eV$, $n_i (Ge) = 2.5 \times 10^{13}/cm^3$.

1. Comment on the following with brief and to the point logical explanation:

[1+1+1+2]

- (a) Variation of band gap with doping.
- (b) Variation of band gap with temperature.
- (c) Variation of lattice controlled mobility with temp.
- (d) Variation of intrinsic carrier concentrations (n_i) with temp and band gap (E_g) .
- 2. Write brief note on followings:

[2 * 5 = 10]

- (a) Thermal Runway
- (b) Base narrowing effect and early effect
- (c) Enhancement mode MOSFET
- (d) p-i-n diode
- (e) Hall effect
- 3. A metal-semiconductor (MS) junction is made between a metal of work function $q\phi_m = 4.6 \text{ eV}$ and a p-type Si doped with $1.5 \times 10^{14} \text{ /cm}^3$ at room temp. Sketch and label the energy band diagrams across the MS junction before contact and after contact. $[q\chi_{\text{Si}} = 4.05 \text{ eV}]$.
- 4. Consider a Ge crystal at room temperature doped with $5x10^{17}$ /cm³ As atoms. Find [5] equilibrium electron, hole concentrations and position of the Fermi level w.r.t intrinsic energy level (E_i) and conduction energy band (E_c). Draw the energy band diagram also.
- 5. For a Si bar having length 4 μ m. doped n-type at 10^{17} /cm³. Calculate the current for an [5] applied voltage of 2 V having a cross sectional area of 0.01 cm². If the voltage is now raised at 100 V what will be the change in current? Electron and hole mobility are 1350 cm²/V-sec and 400 cm²/ V-sec for low electric field. For higher field, saturation velocity for electron is $V_s = 10^7$ cm/sec.

6. Consider a Si sample kept at room temperature having band gap $E_g = 1.12$ eV. [5] (a) If the Fermi level E_F, is located exactly at the middle of the band gap for this sample, then what will be the probability of finding an electron at $E = E_C + 2KT$. (b) If the Fermi level E_F , is located such that $E_F = E_V$, then what will be the probability of finding an electron at $E = E_V + KT$. Note: Put "Tick $(\sqrt{\ })$ " Marks on the write option wherever applicable (Bold) / Fill in the blanks. 7. (a) In an npn Si/Si_{1-x}Ge_x heterojunction bipolar transistor (HBT), base is heavily/ lightly [2] doped and increases the **hole/electron** injection efficiency. (b) Body or substrate bias effect increases/ decreases the current in MOSFETs and [2] Boron ion implantation increases/ decreases the threshold voltage (V_r) in n-channel MOSFETs. (c) Usually in MOS scaling, the oxide layer thickness increases/ decreases and gate [2] capacitance of the device increases/ decreases. (d) Substrate leakage current in n-MOS devices are due to secondary electrons/ holes [2] and this current increases/reduces at higher gate voltage. (e) Avalanche breakdown voltage increases/ decreases as band gap of the [2] semiconductor increases and this voltage increases/ decreases as doping of the lighter region decreases. The probability of finding an electron at an energy level 4kT above the Fermi level would be $__0.0183$ and number of electrons would be $0.0183x10^{19}$ /cm³ if the density of states is 1019 /cm3.

(g) For a Si at a given temperature it is found that $1x10^{10}$ electrons/ cm³ have moved from valance band (VB) to conduction band (CB) when density of atoms is 10^{22} /cm³. Then number of holes in the VB would be _____10^{10}_____ and this will be a factor of value

 10^{-11} of the total available electrons in the VB.

Useful Equations

Fermi-Dirac
$$e^-$$
 distribution: $f(E) = \frac{1}{e^{(E-E,VkT}+1)} = e^{(E_t-E)VkT}$ for $E \gg E_F$.

Equilibrium:
$$n_0 = \int_{E_c}^{\infty} f(E)N(E)dE = N_c f(E_c) = N_c e^{-(E_c - E_c)/kT}$$

$$N_c = 2\left(\frac{2\pi m_n^* kT}{h^2}\right)^{3/2} \quad N_v = 2\left(\frac{2\pi m_p^* kT}{h^2}\right)^{3/2} \quad n_0 = n_i e^{(E_r - E_s)/kT} \\ p_0 = n_i e^{(E_r - E_s)/kT} \quad n_0 p_0 = n_i^2$$

$$p_0 = N_v[1 - f(E_v)] = N_v e^{-(E_f - E_v)/kT}$$

$$n_i = N_c e^{-(E_c - E_c)/kT}, \quad p_i = N_c e^{-(E_c - E_c)/kT} \quad n_i = \sqrt{N_c N_c} e^{-E_c/2kT} = 2\left(\frac{2\pi kT}{h^2}\right)^{3/2} (m_n^* m_p^*)^{3/4} e^{-E_c/2kT}$$

$$n = Ne^{-(E_r - F_n)/kT} = n_i e^{(F_n - E_n)/kT}$$

$$p = Ne^{-(F_n - E_n)/kT} = n_i e^{(E_n - E_n)/kT}$$

$$np = n_i^2 e^{(F_n - F_n)/kT}$$

$$\frac{d\mathscr{E}(x)}{dx} = -\frac{d^2\mathscr{V}(x)}{dx^2} = \frac{\rho(x)}{\epsilon} = \frac{q}{\epsilon} (p - n + N_d^+ - N_a^-) \qquad \mathscr{E}(x) = -\frac{d\mathscr{V}(x)}{dx} = \frac{1}{q} \frac{dE_i}{dx}$$

$$\frac{I_x}{A} = J_x = q(n\mu_n + p\mu_p)\mathcal{E}_x = \sigma\mathcal{E}_x$$

Diffusion length: $L = \sqrt{D_T}$ Einstein relation: $\frac{D}{\mu} = \frac{kT}{q}$

Continuity:
$$\frac{\partial p(x,t)}{\partial t} = \frac{\partial \delta p}{\partial t} = -\frac{1}{q} \frac{\partial J_p}{\partial x} - \frac{\delta p}{\tau_p} \frac{\partial \delta n}{\partial t} = \frac{1}{q} \frac{\partial J_n}{\partial x} - \frac{\delta n}{\tau_n}$$

For steady state diffusion:
$$\frac{d^2\delta n}{dx^2} = \frac{\delta n}{D_n \tau_n} = \frac{\delta n}{L_n^2} = \frac{d^2\delta p}{dx^2} = \frac{\delta p}{L_p^2}$$

Equilibrium:
$$V_0 = \frac{kT}{q} \ln \frac{p_\rho}{p_n} = \frac{kT}{q} \ln \frac{N_a}{n_i^2/N_d} = \frac{kT}{q} \ln \frac{N_a N_d}{n_i^2}$$

$$\frac{p_\rho}{p_n} = \frac{n_n}{n_c} = e^{qV_c kT}$$

$$W = \left[\frac{2e(V_a - V)}{q} \left(\frac{N_a + N_d}{N_c N_c}\right)\right]^{1/2}$$

Junction Depletion:
$$C_i = \epsilon A \left[\frac{q}{2\epsilon (V_0 - V)} \frac{N_d N_u}{N_d + N_u} \right]^{1/2} = \frac{\epsilon A}{W}$$

One-sided abrupt
$$p^*$$
- n : $x_{ab} = \frac{WN_a}{N_a + N_d} = W$ $V_0 = \frac{qN_dW^2}{2\epsilon}$

$$\Delta p_n = p(x_{n0}) - p_n = p_n(e^{\rho V_n kT} - 1)$$

$$\delta p(x_n) = \Delta p_n e^{-x_n/t_n} = p_n (e^{qV\cdot kT} - 1)e^{-x_n/t_n}$$

Ideal diode:
$$I = qA \left(\frac{D_p}{L_p} p_n + \frac{D_n}{L_n} n_p \right) (e^{qV/kT} - 1) = I_0 (e^{qV/kT} - 1)$$

Stored charge exp. hole dist.:
$$Q_n = qA \int_0^\infty \delta p(x_n) dx_n = qA \Delta p_n \int_0^\infty e^{-i\varphi L_n} dx_n = qA L_p \Delta p_n$$

$$I_{p}(x_{n}=0) = \frac{Q_{p}}{\tau_{p}} = qA \frac{L_{p}}{\tau_{p}} \Delta p_{n} = qA \frac{D_{p}}{L_{p}} p_{n}(e^{\eta V, kT} - 1)$$

$$l_{Ep} = qA \frac{D_{\rho}}{L_{\rho}} \left(\Delta p_E \coth \frac{W_b}{L_{\rho}} - \Delta p_C \operatorname{csch} \frac{W_b}{L_{\rho}} \right)$$

$$I_C = qA \frac{D_p}{L_p} \left(\Delta p_E \operatorname{csch} \frac{W_b}{L_p} - \Delta p_C \operatorname{ctnh} \frac{W_b}{L_p} \right) \quad \text{Substrate bias:} \quad \Delta V_T \simeq \frac{\sqrt{2\epsilon_s q N_s}}{C_i} (-V_B)^{1/2}$$

Oxide:
$$C_i = \frac{\epsilon_i}{d}$$
 Depletion: $C_d = \frac{\epsilon_s}{W}$ MOS: $C = \frac{C_i C_d}{C_i + C_d}$

Inversion:
$$\phi_s(\text{inv.}) = 2\phi_F = 2\frac{kT}{q}\ln\frac{N_a}{n_c}$$
 (6-15) $W = \left[\frac{2\epsilon_s\phi_s}{qN_a}\right]^{1/2}$

$$Q_d = -qN_aW_m = -2(\epsilon_s qN_a\phi_F)^{1/2}$$
 (6-32) At V_{FB} : $C_{FB} = \frac{C_i C_{dehye}}{C_i + C_{dehye}}$

$$\Delta p_E = p_n (e^{qV_{EB}/kT} - 1)$$

$$\Delta p_C = p_n (e^{qV_{CB}/kT} - 1)$$

$$B = \frac{I_C}{I_{E_p}} = \frac{\operatorname{csch} W_b/L_p}{\operatorname{ctnh} W_b/L_p} = \operatorname{sech} \frac{W_b}{L_p} \approx 1 - \left(\frac{W_b^2}{2L_p^2}\right)$$

(Base transport factor)

$$\gamma = \frac{I_{Ep}}{I_{Ep} + I_{Eq}} = \left[1 + \frac{L_p^n n_n \mu_n^p}{L_p^n n_n \mu_n^p} \tanh \frac{W_b}{L_n^n} \right]^{-1} = \left[1 + \frac{W_b n_n \mu_n^p}{L_p^n n_n \mu_n^p} \right]^{-1}$$

(Emitter injection efficiency)

$$\frac{i_C}{i_E} = B\gamma = \alpha \quad (7-3) \qquad \qquad \frac{i_C}{i_B} = \frac{B\gamma}{1 - B\gamma} = \frac{\alpha}{1 - \alpha} = \beta \quad \frac{i_C}{i_B} = \beta = \frac{\tau_p}{\tau_t}$$

(Common base gain) (Common emitter gain)

(For $\gamma = 1$)

 $I_B = qA \frac{D_p}{I} \left[(\Delta p_E + \Delta p_C) \tanh \frac{W_h}{2I} \right]$